



PALM INTRANET

Day : Friday  
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## Inventor Name Search Result

Your Search was:

Last Name = YAMAGUCHI

First Name = TAKAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name 51
<u>60545697</u>	Not Issued	020	02/18/2004	FREQUENCY-DOMAIN BASED METHOD FOR MEASURING DETERMINISTIC JITTER	YAMAGUCHI, TAKAHIRO
<u>10779905</u>	<u>6828815</u>	150	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>10779904</u>	Not Issued	020	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>10713280</u>	Not Issued	030	11/15/2003	POSITION DETECTION APPARATUS, POSITION DETECTION METHOD, ELECTRONIC PART CARRYING APPARATUS, AND ELECTRONIC BEAM EXPOSURE APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10699345</u>	Not Issued	030	11/03/2003	OPTICAL DISK REPRODUCING APPARATUS AND METHOD FOR CONTROLLING SPINDLE MOTOR	YAMAGUCHI, TAKAHIRO
<u>10463471</u>	Not Issued	030	06/18/2003	OPTICAL TRANSMITTER/RECEIVER MODULE	YAMAGUCHI, TAKAHIRO
<u>10453623</u>	Not Issued	092	06/04/2003	ROTARY PUMP FOR BRAKING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10382993</u>	Not Issued	030	03/07/2003	OPTICAL DISC APPARATUS	YAMAGUCHI, TAKAHIRO
<u>10369199</u>	Not Issued	061	02/20/2003	BRAKE APPARATUS WITH ORIFICES FOR RESTRICTING BRAKE FLUID PRESSURE PULSATION	YAMAGUCHI, TAKAHIRO
<u>10298841</u>	Not	030	11/18/2002	RELAY APPARATUS AND	YAMAGUCHI,

	Issued			RELAY METHOD SUITABLE FOR PERFORMING COMMUNICATION TO ENSURE QUALITY OF SERVICE	TAKAHIRO
<u>10279996</u>	<u>6783193</u>	150	10/25/2002	ROTARY PUMP AND BRAKING APPARATUS USING ROTARY PUMP	YAMAGUCHI, TAKAHIRO
<u>10265349</u>	Not Issued	041	10/04/2002	MEASUREMENT APPARATUS AND MEASURING METHOD	YAMAGUCHI, TAKAHIRO
<u>10260724</u>	Not Issued	030	09/30/2002	JITTER MEASUREMENT APPARATUS AND JITTER MEASUREMENT METHOD	YAMAGUCHI, TAKAHIRO
<u>10240182</u>	Not Issued	041	09/27/2002	JITTER ESTIMATING DEVICE AND ESTIMATING METHOD	YAMAGUCHI, TAKAHIRO
<u>10214472</u>	Not Issued	041	08/07/2002	PROCESSING APPARATUS, PROCESSING METHOD AND POSITION DETECTING DEVICE	YAMAGUCHI, TAKAHIRO
<u>10214443</u>	<u>6749272</u>	150	08/08/2002	ROTARY PUMP WITH HIGHER DISCHARGE PRESSURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
<u>10205592</u>	Not Issued	041	07/25/2002	ELECTRONIC DEVICE WITH INTEGRALLY FORMED LIGHT EMITTING DEVICE AND SUPPORTING MEMBER	YAMAGUCHI, TAKAHIRO
<u>10134298</u>	Not Issued	030	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	YAMAGUCHI, TAKAHIRO
<u>10082563</u>	Not Issued	030	02/23/2002	PROBABILITY ESTIMATING APPARATUS AND METHOD FOR PEAK-TO-PEAK CLOCK SKEWS	YAMAGUCHI, TAKAHIRO
<u>10082307</u>	Not Issued	164	02/26/2002	PLANAR PACKAGED OPTICAL MODULE AND TRANSMISSION SUBSTRATE USING PLANAR PACKAGE OPTICAL MODULE	YAMAGUCHI, TAKAHIRO
<u>10053882</u>	<u>6715847</u>	150	01/24/2002	ROTARY PUMP WITH HIGHER DISCHARGE PRESSURE AND BRAKE APPARATUS HAVING SAME	YAMAGUCHI, TAKAHIRO
<u>10033533</u>	Not Issued	161	10/25/2001	GUI PROCESSING SYSTEM FOR PERFORMING AN OPERATION OF AN APPLICATION WHICH	YAMAGUCHI, TAKAHIRO

				CONTROLS TESTING EQUIPMENT	
<u>10033188</u>	<u>6737852</u>	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	YAMAGUCHI, TAKAHIRO
<u>09995402</u>	Not Issued	161	11/26/2001	AUTOMATIC REMOTE ELECTRONIC INSTRUMENT CONNECTING SYSTEM AND METHOD	YAMAGUCHI, TAKAHIRO
<u>09980891</u>	<u>6801049</u>	150	12/03/2001	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09925230</u>	<u>6476742</u>	150	08/08/2001	EVALUATION SYSTEM FOR ANALOG-DIGITAL OR DIGITAL-ANALOG CONVERTER	YAMAGUCHI, TAKAHIRO
<u>09905882</u>	Not Issued	030	07/17/2001	DISK REPRODUCING APPARATUS	YAMAGUCHI, TAKAHIRO
<u>09897024</u>	<u>6474752</u>	150	07/03/2001	ROTARY PUMP AND BRAKING DEVICE USING SAME	YAMAGUCHI, TAKAHIRO
<u>09882290</u>	Not Issued	030	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	YAMAGUCHI, TAKAHIRO
<u>09880976</u>	<u>6461882</u>	150	06/13/2001	FAULT SIMULATION METHOD AND FAULT SIMULATOR FOR SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09876389</u>	Not Issued	030	06/06/2001	METHOD AND APPARATUS FOR GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09835824</u>	Not Issued	041	04/17/2001	ADAPTER FOR CONTROLLING A MEASURING DEVICE, A MEASURING DEVICE, A CONTROLLER FOR A MEASURING DEVICE, A METHOD FOR PROCESSING MEASUREMENT AND A RECORDING MEDIUM	YAMAGUCHI, TAKAHIRO
<u>09826295</u>	<u>6594595</u>	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	YAMAGUCHI, TAKAHIRO
<u>09813923</u>	Not	030	03/20/2001	APPARATUS FOR AND	YAMAGUCHI,

	Issued			METHOD OF MEASURING CLOCK SKEW	TAKAHIRO
<u>09811153</u>	Not Issued	071	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	YAMAGUCHI, TAKAHIRO
<u>09722167</u>	6525523	150	11/24/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	YAMAGUCHI, TAKAHIRO
<u>09703469</u>	6775321	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO
<u>09702278</u>	Not Issued	160	10/30/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09699077</u>	Not Issued	061	10/27/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09697294</u>	6478477	150	10/27/2000	PLANAR PACKAGED OPTICAL MODULE HAVING 1ST AND 2ND ADHESIVES WITH DIFFERENT GLASS- TRANSITION TEMPERATURES	YAMAGUCHI, TAKAHIRO
<u>09694680</u>	6474751	150	10/24/2000	HYDRAULIC CIRCUIT HAVING A ROTARY TYPE PUMP AND BRAKE APPARATUS FOR A VEHICLE PROVIDED WITH THE SAME	YAMAGUCHI, TAKAHIRO
<u>09663700</u>	6593765	150	09/15/2000	TESTING APPARATUS AND TESTING METHOD FOR SEMICONDUCTOR INTEGRATED CIRCUIT	YAMAGUCHI, TAKAHIRO
<u>09650000</u>	6598004	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	YAMAGUCHI, TAKAHIRO
<u>09647908</u>	6795496	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	YAMAGUCHI, TAKAHIRO
<u>09634734</u>	6333766	150	08/08/2000	TONE DISPLAY METHOD AND APPARATUS FOR DISPLAYING IMAGE SIGNAL	YAMAGUCHI, TAKAHIRO
<u>09538186</u>	6735538	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	YAMAGUCHI, TAKAHIRO

<a href="#">09538135</a>	<a href="#">6460001</a>	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	YAMAGUCHI, TAKAHIRO
<a href="#">09528720</a>	Not Issued	161	03/20/2000	MEASURING METHOD BY SPECTRUM ANALYZER	YAMAGUCHI, TAKAHIRO
<a href="#">09512780</a>	<a href="#">6423558</a>	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC) DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	YAMAGUCHI, TAKAHIRO
<a href="#">09494321</a>	<a href="#">6400129</a>	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	YAMAGUCHI, TAKAHIRO
<a href="#">09408280</a>	<a href="#">6687629</a>	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	YAMAGUCHI, TAKAHIRO

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## PALM INTRANET

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## Inventor Name Search Result

Your Search was:

Last Name = ISHIDA

First Name = MASAHIRO

Application#	Patent#	Status	Date Filed	Title	Inventor Name 51
<a href="#">60545697</a>	Not Issued	020	02/18/2004	FREQUENCY-DOMAIN BASED METHOD FOR MEASURING DETERMINISTIC JITTER	ISHIDA, MASAHIRO
<a href="#">60277251</a>	Not Issued	159	03/20/2001	APPARATUS AND METHOD FOR ESTIMATING PROBABILITY OF PEAK-TO-PEAK VALUE OF CLOCK SKEW	ISHIDA, MASAHIRO
<a href="#">29150337</a>	<a href="#">D460402</a>	150	11/21/2001	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<a href="#">29150336</a>	<a href="#">D467535</a>	150	11/21/2001	AUTOMOBILE TIRE	ISHIDA, MASAHIRO
<a href="#">10779905</a>	<a href="#">6828815</a>	150	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<a href="#">10779904</a>	Not Issued	020	02/17/2004	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<a href="#">10459438</a>	<a href="#">6797991</a>	150	06/12/2003	NITRIDE SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<a href="#">10457362</a>	Not Issued	071	06/10/2003	SEMICONDUCTOR WAFER, SEMICONDUCTOR DEVICE, AND METHODS FOR FABRICATING THE SAME	ISHIDA, MASAHIRO
<a href="#">10442301</a>	Not Issued	094	05/21/2003	METHOD FOR FABRICATING SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<a href="#">10413995</a>	Not Issued	041	04/16/2003	SEMICONDUCTOR SUBSTRATE, METHOD OF MANUFACTURING THE SEMICONDUCTOR SUBSTRATE,	ISHIDA, MASAHIRO

				SEMICONDUCTOR DEVICE AND PATTERN FORMING METHOD	
<u>10405791</u>	<u>6773948</u>	150	04/02/2003	SEMICONDUCTOR LIGHT EMITTING DEVICE AND METHOD FOR PRODUCING THE SAME	ISHIDA, MASAHIRO
<u>10145144</u>	<u>6750158</u>	150	05/15/2002	METHOD FOR PRODUCING A SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>10134298</u>	Not Issued	030	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	ISHIDA, MASAHIRO
<u>10118924</u>	<u>6723165</u>	150	04/10/2002	METHOD FOR FABRICATING GROUP III NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10100118</u>	<u>6589857</u>	150	03/19/2002	MANUFACTURING METHOD OF SEMICONDUCTOR FILM	ISHIDA, MASAHIRO
<u>10082563</u>	Not Issued	030	02/23/2002	PROBABILITY ESTIMATING APPARATUS AND METHOD FOR PEAK-TO-PEAK CLOCK SKEWS	ISHIDA, MASAHIRO
<u>10062512</u>	<u>6562701</u>	150	02/05/2002	METHOD OF MANUFACTURING NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>10033188</u>	<u>6737852</u>	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	ISHIDA, MASAHIRO
<u>10032563</u>	Not Issued	095	01/02/2002	METHOD OF MANUFACTURING NITRIDE SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>09986997</u>	Not Issued	071	11/13/2001	METHOD FOR FABRICATING SEMICONDUCTOR DEVICE HAVING GROUP III NITRIDE	ISHIDA, MASAHIRO
<u>09980891</u>	<u>6801049</u>	150	12/03/2001	METHOD AND APPARATUS FOR DEFECT ANALYSIS OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09921885</u>	<u>6562644</u>	150	08/06/2001	SEMICONDUCTOR SUBSTRATE, METHOD OF MANUFACTURING THE SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND PATTERN FORMING METHOD	ISHIDA, MASAHIRO

<u>09882290</u>	Not Issued	030	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	ISHIDA, MASAHIRO
<u>09880976</u>	<u>6461882</u>	150	06/13/2001	FAULT SIMULATION METHOD AND FAULT SIMULATOR FOR SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09876389</u>	Not Issued	030	06/06/2001	METHOD AND APPARATUS FOR GENERATING TEST PATTERNS USED IN TESTING SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09864218</u>	<u>6569238</u>	150	05/25/2001	APPARATUS AND METHOD FOR DEPOSITING SEMICONDUCTOR FILM	ISHIDA, MASAHIRO
<u>09826295</u>	<u>6594595</u>	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	ISHIDA, MASAHIRO
<u>09813923</u>	Not Issued	030	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING CLOCK SKEW	ISHIDA, MASAHIRO
<u>09811153</u>	Not Issued	071	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	ISHIDA, MASAHIRO
<u>09790908</u>	<u>6566231</u>	150	02/23/2001	METHOD OF MANUFACTURING HIGH PERFORMANCE SEMICONDUCTOR DEVICE WITH REDUCED LATTICE DEFECTS IN THE ACTIVE REGION	ISHIDA, MASAHIRO
<u>09758287</u>	<u>6358770</u>	150	01/12/2001	METHOD FOR GROWING NITRIDE SEMICONDUCTOR CRYSTALS, NITRIDE SEMICONDUCTOR DEVICE, AND METHOD FOR FABRICATING THE SAME	ISHIDA, MASAHIRO
<u>09748436</u>	<u>6673702</u>	150	12/26/2000	METHOD FOR PRODUCING A SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>09729424</u>	<u>6653663</u>	150	12/05/2000	NITRIDE SEMICONDUCTOR DEVICE	ISHIDA, MASAHIRO
<u>09722167</u>	<u>6525523</u>	150	11/24/2000	JITTER MEASUREMENT APPARATUS AND ITS	ISHIDA, MASAHIRO



				METHOD	
<u>09703469</u>	<u>6775321</u>	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO
<u>09702695</u>	<u>6440790</u>	150	11/01/2000	METHOD OF MAKING SEMICONDUCTOR DEVICE HAVING AN ISULATING FILM POSITIONED BETWEEN TWO SIMILARLY SHAPED CONDUCTIVE FILMS	ISHIDA, MASAHIRO
<u>09702278</u>	Not Issued	160	10/30/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09699077</u>	Not Issued	061	10/27/2000	METHOD AND APPARATUS FOR FAULT SIMULATION OF SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09680054</u>	<u>6821805</u>	150	10/05/2000	SEMICONDUCTOR DEVICE, SEMICONDUCTOR SUBSTRATE, AND MANUFACTURE METHOD	ISHIDA, MASAHIRO
<u>09663700</u>	<u>6593765</u>	150	09/15/2000	TESTING APPARATUS AND TESTING METHOD FOR SEMICONDUCTOR INTEGRATED CIRCUIT	ISHIDA, MASAHIRO
<u>09650000</u>	<u>6598004</u>	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	ISHIDA, MASAHIRO
<u>09647908</u>	<u>6795496</u>	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	ISHIDA, MASAHIRO
<u>09623944</u>	Not Issued	161	09/12/2000	PRO-FRAGRANCE SILICONE POLYMER AND COMPOSITIONS THEREOF	ISHIDA, MASAHIRO
<u>09546881</u>	<u>6274518</u>	150	04/10/2000	METHOD FOR PRODUCING A GROUP III NITRIDE COMPOUND SEMICONDUCTOR SUBSTRATE	ISHIDA, MASAHIRO
<u>09538186</u>	<u>6735538</u>	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	ISHIDA, MASAHIRO
<u>09538135</u>	<u>6460001</u>	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	ISHIDA, MASAHIRO

<a href="#">09532063</a>	<a href="#">6593159</a>	150	03/21/2000	SEMICONDUCTOR SUBSTRATE, SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME	ISHIDA, MASAHIRO
<a href="#">09512780</a>	<a href="#">6423558</a>	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC) DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	ISHIDA, MASAHIRO
<a href="#">09511371</a>	<a href="#">6420197</a>	150	02/23/2000	SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING THE SAME	ISHIDA, MASAHIRO
<a href="#">09494321</a>	<a href="#">6400129</a>	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE- LOCKED LOOP CIRCUIT	ISHIDA, MASAHIRO
<a href="#">09408280</a>	<a href="#">6687629</a>	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	ISHIDA, MASAHIRO

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**PALM INTRANET**

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**Inventor Name Search Result**

Your Search was:

Last Name = SOMA

First Name = MANI

Application#	Patent#	Status	Date Filed	Title	Inventor Name 39
<a href="#">60545697</a>	Not Issued	020	02/18/2004	FREQUENCY-DOMAIN BASED METHOD FOR MEASURING DETERMINISTIC JITTER	SOMA, MANI
<a href="#">60529948</a>	Not Issued	159	12/15/2003	METHOD TO MEASURE RF TRANSMITTER BANDWIDTH IN TIME DOMAIN	SOMA, MANI
<a href="#">60416033</a>	Not Issued	159	10/04/2002	FREQUENCY AND PHASE MEASUREMENTS USING THE MORLET TRANSFORM	SOMA, MANI
<a href="#">60415975</a>	Not Issued	159	10/04/2002	TIMING PARAMETER EXTRACTION METHODS USING THE HAAR WAVELET	SOMA, MANI
<a href="#">60277251</a>	Not Issued	159	03/20/2001	APPARATUS AND METHOD FOR ESTIMATING PROBABILITY OF PEAK-TO-PEAK VALUE OF CLOCK SKEW	SOMA, MANI
<a href="#">60155634</a>	Not Issued	159	09/23/1999	CHARGE-BASED FREQUENCY MEASUREMENT BIST FOR PLL	SOMA , MANI
<a href="#">60004382</a>	Not Issued	159	09/27/1995	ORTHODONTICS HEADGEAR COMPLIANCE MONITOR	SOMA , MANI
<a href="#">10925870</a>	Not Issued	019	08/25/2004	MEASUREMENT INSTRUMENT AND MEASUREMENT METHOD	SOMA, MANI
<a href="#">10896751</a>	Not Issued	020	07/22/2004	JITTER MEASURING APPARATUS, JITTER MEASURING METHOD AND PLL CIRCUIT	SOMA, MANI
<a href="#">10862904</a>	Not Issued	020	06/07/2004	WIDEBAND SIGNAL ANALYZING APPARATUS, WIDEBAND PERIOD JITTER ANALYZING APPARATUS, AND WIDEBAND SKEW	SOMA, MANI

				ANALYZING APPARATUS	
<u>10824763</u>	Not Issued	020	04/14/2004	TESTING APPARATUS AND TESTING METHOD	SOMA, MANI
<u>10776926</u>	Not Issued	020	02/11/2004	MEASURING APPARATUS AND MEASURING METHOD	SOMA, MANI
<u>10737716</u>	Not Issued	020	12/16/2003	TESTING APPARATUS AND TESTING METHOD	SOMA, MANI
<u>10665970</u>	Not Issued	041	09/18/2003	CHARACTERIZATION OF RADIO FREQUENCY (RF) SIGNALS USING WAVELET-BASED PARAMETER EXTRACTION	SOMA, MANI
<u>10265349</u>	Not Issued	041	10/04/2002	MEASUREMENT APPARATUS AND MEASURING METHOD	SOMA, MANI
<u>10260724</u>	Not Issued	030	09/30/2002	JITTER MEASUREMENT APPARATUS AND JITTER MEASUREMENT METHOD	SOMA, MANI
<u>10240182</u>	Not Issued	041	09/27/2002	JITTER ESTIMATING DEVICE AND ESTIMATING METHOD	SOMA, MANI
<u>10214472</u>	Not Issued	041	08/07/2002	PROCESSING APPARATUS, PROCESSING METHOD AND POSITION DETECTING DEVICE	SOMA, MANI
<u>10205592</u>	Not Issued	041	07/25/2002	ELECTRONIC DEVICE WITH INTEGRALLY FORMED LIGHT EMITTING DEVICE AND SUPPORTING MEMBER	SOMA, MANI
<u>10134298</u>	Not Issued	030	04/29/2002	MEASURING APPARATUS AND MEASURING METHOD	SOMA, MANI
<u>10082563</u>	Not Issued	030	02/23/2002	PROBABILITY ESTIMATING APPARATUS AND METHOD FOR PEAK-TO-PEAK CLOCK SKEWS	SOMA, MANI
<u>10033188</u>	<u>6737852</u>	150	10/25/2001	CLOCK SKEW MEASURING APPARATUS AND METHOD	SOMA, MANI
<u>09882290</u>	Not Issued	030	06/14/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	SOMA, MANI
<u>09826295</u>	<u>6594595</u>	150	04/03/2001	APPARATUS FOR AND METHOD OF MEASURING CROSS-CORRELATION COEFFICIENT BETWEEN SIGNALS	SOMA, MANI
<u>09813923</u>	Not Issued	030	03/20/2001	APPARATUS FOR AND METHOD OF MEASURING	SOMA, MANI

				CLOCK SKEW	
<u>09811153</u>	Not Issued	071	03/16/2001	APPARATUS FOR AND METHOD OF MEASURING JITTER	SOMA, MANI
<u>09722167</u>	<u>6525523</u>	150	11/24/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	SOMA, MANI
<u>09703469</u>	<u>6775321</u>	150	10/31/2000	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
<u>09669487</u>	Not Issued	094	09/25/2000	CHARGE-BASED FREQUENCY MEASUREMENT BIST	SOMA, MANI
<u>09650000</u>	<u>6598004</u>	150	08/28/2000	JITTER MEASUREMENT APPARATUS AND ITS METHOD	SOMA, MANI
<u>09647908</u>	<u>6795496</u>	150	10/05/2000	JITTER MEASURING DEVICE AND METHOD	SOMA, MANI
<u>09538186</u>	<u>6735538</u>	150	03/29/2000	APPARATUS AND METHOD FOR MEASURING QUALITY MEASURE OF PHASE NOISE WAVEFORM	SOMA, MANI
<u>09538135</u>	<u>6460001</u>	150	03/29/2000	APPARATUS FOR AND METHOD OF MEASURING A PEAK JITTER	SOMA, MANI
<u>09512780</u>	<u>6423558</u>	150	02/25/2000	METHOD FOR FABRICATING INTEGRATED CIRCUIT(IC) DIES WITH MULTI-LAYERED INTERCONNECT STRUCTURES	SOMA, MANI
<u>09494321</u>	<u>6400129</u>	150	01/28/2000	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT IN A PHASE-LOCKED LOOP CIRCUIT	SOMA, MANI
<u>09408280</u>	<u>6687629</u>	150	09/29/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA, MANI
<u>09251096</u>	<u>6291979</u>	150	02/16/1999	APPARATUS FOR AND METHOD OF DETECTING A DELAY FAULT	SOMA, MANI
<u>09246458</u>	<u>6621860</u>	150	02/08/1999	APPARATUS FOR AND METHOD OF MEASURING A JITTER	SOMA , MANI
<u>09043659</u>	<u>5980246</u>	150	03/24/1998	ORTHODONTICS HEADGEAR COMPLIANCE MONITOR	SOMA , MANI

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